

#### N-Channel Enhancement Mode MOSFET

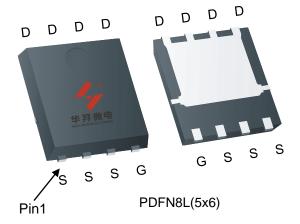
#### **Feature**

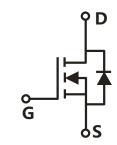
- 40V/264A $R_{DS(ON)} = 0.9 \text{ m}\Omega(typ.) @VGS = 10V$
- 100% Avalanche Tested
- 100% DVDS
- Reliable and Rugged
- MSL1 up to 260<sup>°</sup>C Peak Reflow
- AEC-Q101 Qualified
- 175°C operating temperature
- Halogen Free and Green Devices Available (RoHS Compliant)

# **Applications**

- Switching application
- Li-battery protection
- DC-DC
- Motor control

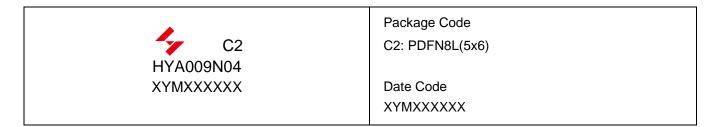
### **Pin Description**





Single N-Channel MOSFET

### **Ordering and Marking Information**



Note: HUAYI halogen free products contain molding compounds/die attach materials and 100% matte tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI halogen free products meet or exceed the halogen free require-ments of IPC/JEDEC J-STD-020 for MSL classification at halogen free peak reflow temperature. HUAYI defines "Green" to mean halogen free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



# **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Unit	
Common Ra	tings (Tc=25°C Unless Otherwise Noted)		•	
VDSS	Drain-Source Voltage		40	V
Vgss	Gate-Source Voltage		±20	V
TJ	Junction Temperature Range			°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode) Tc=25°C		264	А
Mounted on	Large Heat Sink	•	•	•
Ідм	Pulsed Drain Current *	Tc=25°C	792	А
	$I_D$ Continuous Drain Current $Tc=25^{\circ}C$ $Tc=100^{\circ}C$	Tc=25°C	264	Α
ID		Tc=100°C	187	Α
		Tc=25°C	163	W
P <sub>D</sub> Maximum Power Dissipation		Tc=100°C	82	W
$R_{\theta}$ $C$	Thermal Resistance, Junction-to-Case		0.92	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient **		80	°C/W
Eas	Single Pulsed-Avalanche Energy *** L=0.3mH		515	mJ

Note:

- \* Repetitive rating; pulse width limited by max.junction temperature.
- \*\* Surface mounted on 1in2 FR-4 board.
- \*\*\* Limited by TJmax , starting TJ=25°C, L = 0.3mH, Rg=  $25\Omega$ , Vgs =10V.

## **Electrical Characteristics**(Tc =25°C Unless Otherwise Noted)

O. mala al	Donomoton	Took Conditions	HY	A009N04NS1		11
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Static Cha	Static Characteristics					
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V,I <sub>DS</sub> =250μA	40	-	-	V
loss D	Drain-to-Source Leakage Current	Vps=40V,Vgs=0V	-	-	1	μA
		TJ=125°C	-	-	50	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250µA	2.3	3.1	3.7	V
lgss	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	±100	nA
RDS(ON)	Drain-Source On-State Resistance	V <sub>GS</sub> =10V,I <sub>DS</sub> =40A	-	0.9	1.2	mΩ
Diode Characteristics						
VsD	Diode Forward Voltage	Isp=40A,Vgs=0V	-	0.80	1.00	V
trr	Reverse Recovery Time	lon-404 dlon/dt-1004/up	-	39	-	ns
Qrr	Reverse Recovery Charge	- Isb=40A,dIsb/dt=100A/μs	-	33	-	nC



# Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Symbol	Banamatan	Test Conditions  HYA009N0  Min Typ.	A009N04	NS1	11!4	
	Parameter		Min	Тур.	Max	Unit
Dynamic (	Dynamic Characteristics					
Rg	Gate Resistance	V <sub>GS</sub> =0V,V <sub>DS</sub> =0V,F=1MHz	-	1.2	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	4918	-	
Coss	Output Capacitance	V <sub>DS</sub> =25V,	-	1005	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1MHz	-	34	-	
td(ON)	Turn-on Delay Time		-	27	-	
Tr	Turn-on Rise Time	$V_{DD}=20V,R_{G}=4\Omega,$	-	68	-	
td(OFF)	Turn-off Delay Time	Ips=40A,Vgs=10V	-	52	-	ns
Tf	Turn-off Fall Time		-	49	-	
Gate Charge Characteristics						
Qg	Total Gate Charge(V <sub>GS</sub> =10V)		-	66	-	
Qgs	Gate-Source Charge	\/ -22\/   -404	-	27	-	nC
Qgd	Gate-Drain Charge	$V_{DS}$ =32V, $I_{DS}$ =40A	-	7	-	
V <sub>plateau</sub>	Gate plateau voltage		-	5.0	-	V

Note: \*Pulse test, pulse width  $\leq 300$ us, duty cycle  $\leq 2\%$ 



## **Typical Operating Characteristics**

**Figure 1: Power Dissipation** 

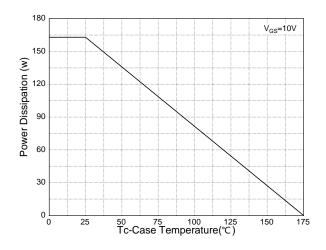


Figure 3: Safe Operation Area

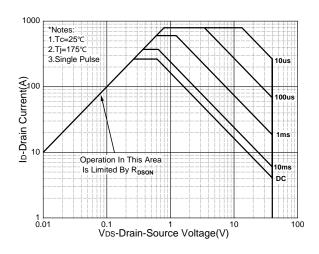
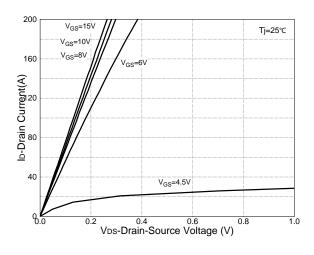
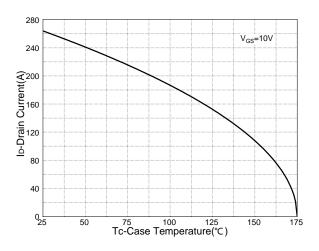


Figure 5: Output Characteristics



**Figure 2: Drain Current** 



**Figure 4: Thermal Transient Impedance** 

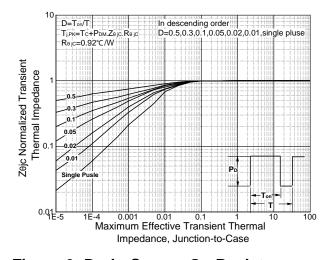
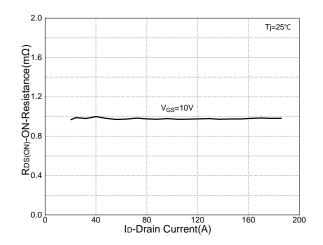


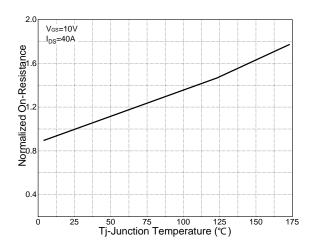
Figure 6: Drain-Source On Resistance





## **Typical Operating Characteristics(Cont.)**

Figure 7: On-Resistance vs. Temperature



**Figure 9: Capacitance Characteristics** 

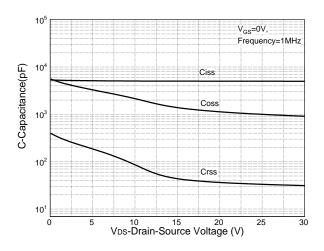


Figure 11: Transfer Characteristics

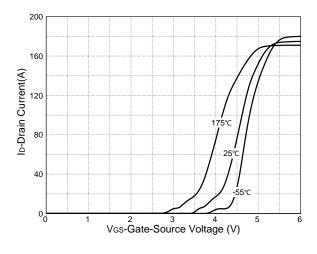
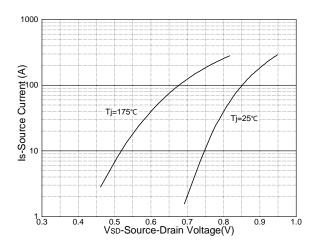


Figure 8: Source-Drain Diode Forward



**Figure 10: Gate Charge Characteristics** 

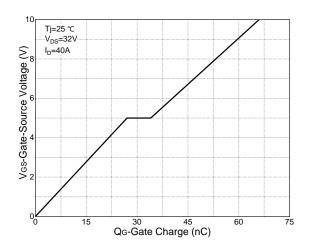
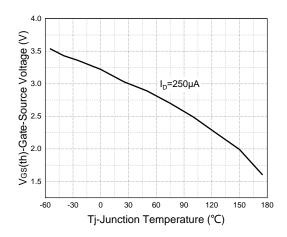


Figure 12: Gate Threshold Voltage





## **Typical Operating Characteristics(Cont.)**

Figure 13: Drain-Source Breakdown

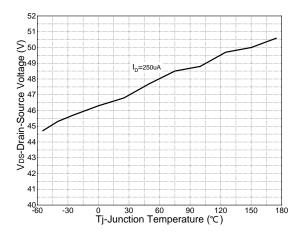


Figure 14: R<sub>dson</sub> vs. Gate Voltage

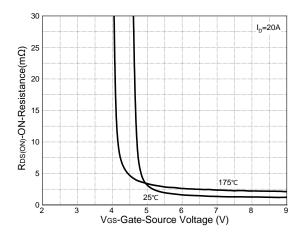
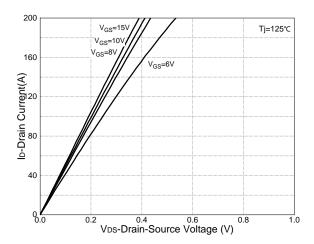
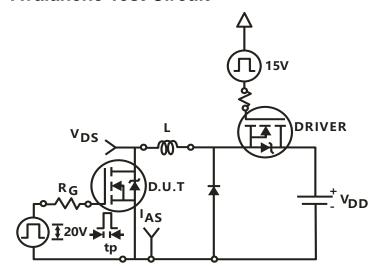


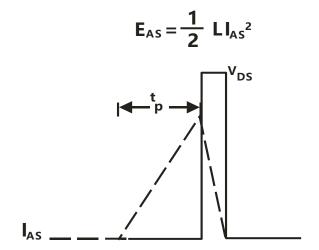
Figure 15: Output Characteristics (125℃)



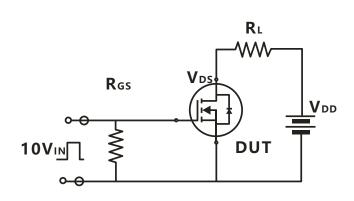


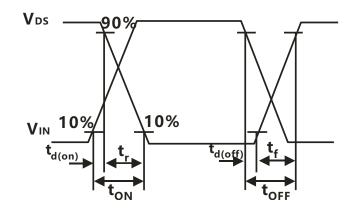
#### **Avalanche Test Circuit**



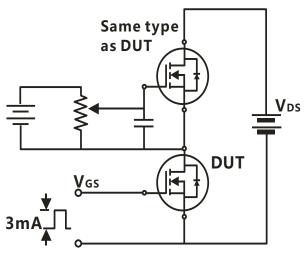


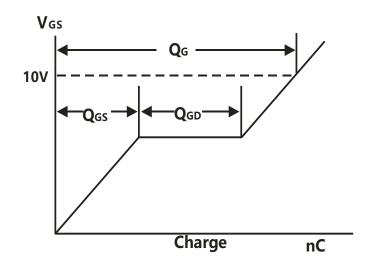
## **Switching Time Test Circuit**





# **Gate Charge Test Circuit**







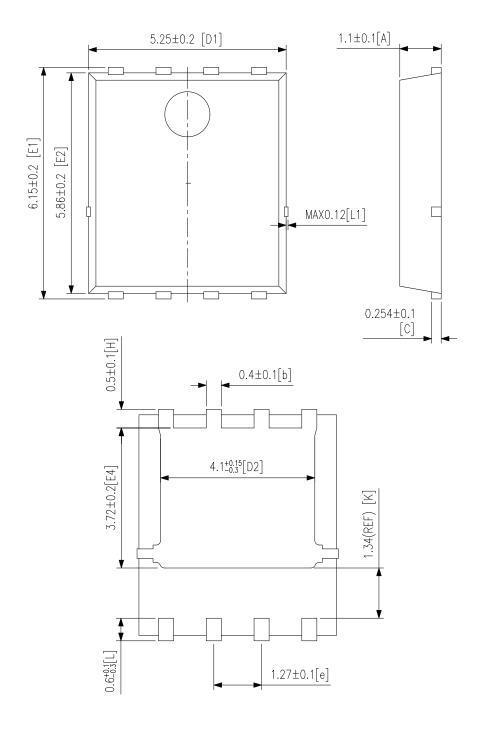
### **Device Per Unit**

Package Type	Unit	Quantity
PDFN8L(5x6)	Reel	5000

# **Package Information**

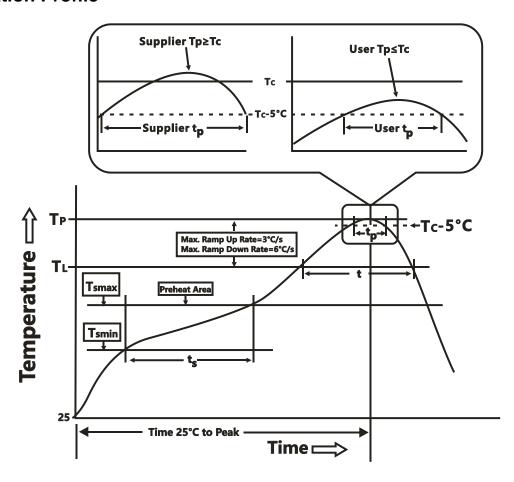
PDFN8L(5x6)

### (unit:mm)





#### **Classification Profile**



#### **Classification Reflow Profiles**

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly		
Preheat & Soak				
Temperature min (T <sub>smin</sub> )	100 °C	150 °C		
Temperature max (T <sub>smax</sub> )	150 °C	200 °C		
Time (Tsmin to Tsmax) (t <sub>s</sub> )	60-120 seconds	60-120 seconds		
Average ramp-up rate (T <sub>smax</sub> to T <sub>P</sub> )	3 °C/second max.	3°C/second max.		
Liquidous temperature (T₁)	183 °C	217 °C		
Time at liquidous (t∟)	60-150 seconds	60-150 seconds		
Peak package body Temperature (T <sub>P</sub> )*	See Classification Temp in table 1	SeeClassification Tempin table 2		
Time (t <sub>P</sub> )** within 5°C of the specified classification temperature (T <sub>c</sub> )	20** seconds	30** seconds		
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.		
Time 25°C to peak temperature	6 minutes max.	8 minutes max.		
+T. ( ) (T.): (C.) (T.): (C.)				

<sup>\*</sup>Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

<sup>\*\*</sup> Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

## **HYA009N04NS1C2**



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm³ <350	Volume mm³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm <sup>3</sup>	Volume mm <sup>3</sup>	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

### **Reliability Test Program**

Test item	Method	Description
PCT	JESD22-A102	121℃,100%RH, 96hours, 205KPa
TCT	JESD22-A104	250/500/1000 Cycles, -55°C~150°C
HTRB	JESD22-A108B	168/500/1000 Hrs, 100% BV <sub>DSS</sub> @ 175℃
HTGB	JESD22-A108B	168/500/1000 Hrs, 100%Vgs @ 175℃
BHAST	JESD22-A110D	130℃,85%RH,230KPA;U=32V
IOL	MIL-STD-750	Ta=25℃,△Tj≥100℃, Ton/Toff 2min ,15000cycles

#### **Customer Service**

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